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# HiRel RadHard Power-MOS

- Low R<sub>DS(on)</sub>
- Total Ionisation Dose (TID) hardened 100 kRad approved (Level R)
- Hermetically sealed
- N-channel

### • **CCCSA** Space Qualified

ESA/SCC Detail Spec. No.: 5205/031 Type Variant No. 03

Туре	Marking	Pin Co	Package			
		1	2	3	4	
BUY15CS23K-01	-	D	S	G	Not connected	TO-257AA

### Maximum Ratings

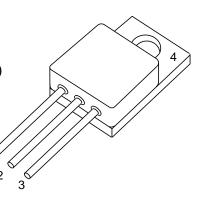
Parameter	Symbol	Values	Unit	
Drain Source Voltage	V <sub>DS</sub>	150	V	
Gate Source Voltage	V <sub>GS</sub>	+/- 20	V	
Drain Gate Voltage	V <sub>DG</sub>	150	V	
Continuous Drain Current $T_c = 25 \ ^{\circ}C$ $T_c = 100 \ ^{\circ}C$	I <sub>D</sub>	23 15	A	
Continuous Source Current	Is	23	А	
Drain Current Pulsed, $t_p$ limited by $T_{jmax}$	I <sub>DM</sub>	93	Apk	
Total Power Dissipation 1)	P <sub>tot</sub>	75	W	
Operating and Storage Temperature	T <sub>op</sub>	-55 to + 150	°C	
Avalanche Energy	E <sub>AS</sub>	90	mJ	

### **Thermal Characteristics**

Thermal Resistance (Junction to Case)	R <sub>th JC</sub>	1.66	K/W
Soldering Temperature	T <sub>sol</sub>	250	°C

#### Notes:

1) For  $T_S \le 25^{\circ}$ C. For  $T_S > 25^{\circ}$ C derating is required.





#### BUY15CS23K-01 Data Sheet

Electrical Characteristics, at T<sub>A</sub>=25°C; unless otherwise specified

Parameter	Symbol		Value	S	Unit
		min.	typ.	max.	
DC Characteristics		•		·	
Breakdown Voltage Drain to Source $I_D = 0.25 \text{mA}, V_{GS} = 0 \text{V}$	B <sub>VDSS</sub>	150	-	-	V
Temperature Coefficient of B <sub>VDSS</sub>	$\Delta BV_{DSS}/\Delta T_{J}$	-	0.20	-	V/°C
Gate Threshold Voltage I <sub>D</sub> = 1.0mA, V <sub>DS</sub> ≥ V <sub>GS</sub>	V <sub>GS(th)</sub>	2.0	-	4.0	V
Gate to Source Leakage Current V <sub>DS</sub> = 0V, V <sub>GS</sub> = +/- 20V	I <sub>GSS</sub>	-	-	+/-100	nA
Drain Current V <sub>DS</sub> = 120V, V <sub>GS</sub> = 0V	I <sub>DSS</sub>	-	-	25	μA
Drain Source On Resistance <sup>1)</sup> $V_{GS} = 10V, I_D = 15A$	R <sub>DS(ON)</sub>	-	55	60	mΩ
Source Drain Diode, Forward Voltage <sup>1), 2)</sup> $V_{GS} = 0V$ , $I_S = 23A$	V <sub>SD</sub>	-	-	1.3	V
AC Characteristics					
Turn-on Delay Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 15A, $R_G$ = 4.7 $\Omega$	t <sub>d(ON)</sub>	-	11	30	ns
Rise Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 15A, $R_G$ = 4.7 $\Omega$	t <sub>r</sub>	-	8	50	ns
Turn-off Delay Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 15A, $R_G$ = 4.7 $\Omega$	$t_{\text{d}(\text{OFF})}$	-	19	40	ns
Fall Time $V_{DD}$ = 50% $V_{DS}$ , $I_D$ = 15A, $R_G$ = 4.7 $\Omega$	t <sub>f</sub>	-	6	40	ns
Reverse Recovery Time V <sub>DD</sub> < 50% V <sub>DS</sub> , I <sub>D</sub> = 23A	t <sub>rr</sub>	-	220	300	ns
Common Source Input Capacitance $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$	C <sub>iss</sub>	1000	1500	1700	pF
Common Source Output Capacitance $V_{DS} = 100V, V_{GS} = 0V, f = 1.0MHz$	C <sub>oss</sub>	140	160	200	pF
Common Source Reverse Transfer Capacitance V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V, f = 1.0MHz	C <sub>rss</sub>	5	23	30	pF
Gate Resistance	R <sub>G</sub>	-	1.4	-	Ω
Total Gate Charge V <sub>DD</sub> = 50% V <sub>DS</sub> , V <sub>GS</sub> = 10V, I <sub>D</sub> = 23A	Q <sub>G</sub>	-	-	32	nC

Notes: 1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%. 2) Measured within 2.0 mm of case.



## **Electrical Characteristics**

at T<sub>A</sub>=125°C; unless otherwise specified

Parameter	Symbol	Values		Unit	
		min.	max.		
DC Characteristics	·		ŀ		
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	V <sub>GS(th)</sub>	1.5	-	V	
Gate to Source Leakage Current $V_{DS} = 0V, V_{GS} = +/-20V$	I <sub>GSS</sub>	-	+/-200	nA	
Drain Current $V_{DS} = 120V, V_{GS} = 0V$	I <sub>DSS</sub>	-	250	μA	
Drain Source On Resistance <sup>1)</sup> $V_{GS} = 10V, I_D = 15A$	r <sub>DS(ON)</sub>	-	110	mΩ	

Notes: 1) Pulsed Measurement: Pulse Width < 300µs, Duty Cycle <2.0%.

### **Electrical Characteristics**

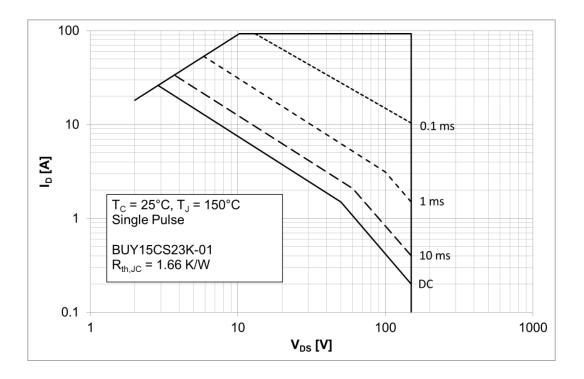
at T<sub>A</sub>=-55°C; unless otherwise specified

Parameter	Symbol	Values		Unit		
		min.	max.			
DC Characteristics						
Gate Threshold Voltage $I_D = 1.0 \text{mA}, V_{DS} \ge V_{GS}$	V <sub>GS(th)</sub>	-	5.0	V		



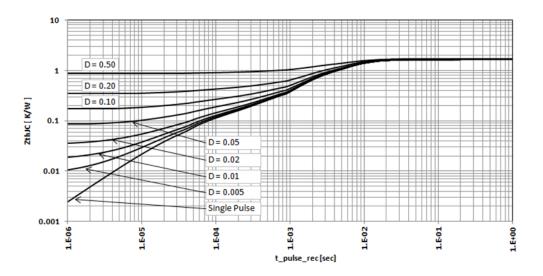
### 1 Safe operating area

 $I_D = f(V_{DS}); T_C = 25^{\circ}C$ parameter:  $t_p$ 



### 2 Max. transient thermal impedance

 $Z_{thJC} = f(t_p)$ parameter: D =  $t_p/T$ 



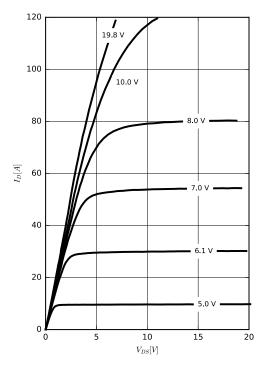


## Data Sheet

# BUY15CS23K-01

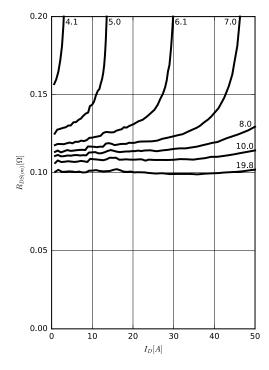
### 3 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \ ^{\circ}C$ parameter:  $V_{GS}$ 



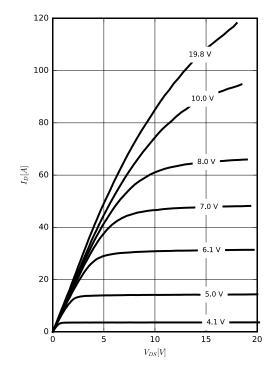
# 5 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 150 \ ^{\circ}C$  parameter:  $V_{GS}$ 



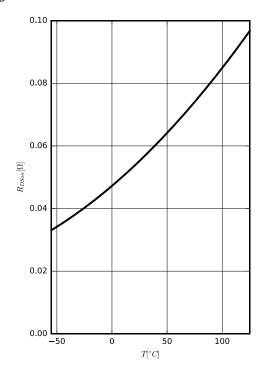
### 4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150 \ ^{\circ}C$ parameter:  $V_G$ 



# 6 Typ. drain-source on-state resistance

 $\begin{array}{l} R_{DS(on)} = f(T_j) \\ I_D = 15A \end{array}$ 



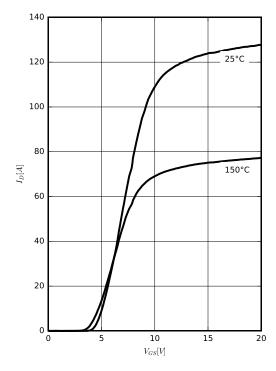


# Data Sheet

# BUY15CS23K-01

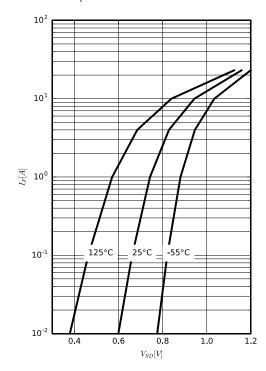
### 7 Typ. transfer characteristics

 $I_D = f(V_{GS}); VDS = 10V$ parameter:  $T_i$ 



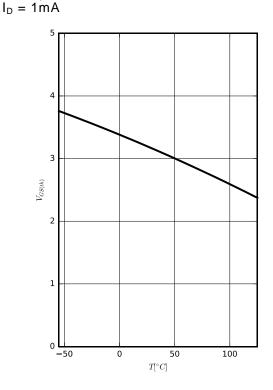
# 9 Typ. forward characteristics of reverse diode

I<sub>F</sub> = f(V<sub>SD</sub>) parameter: T<sub>i</sub>



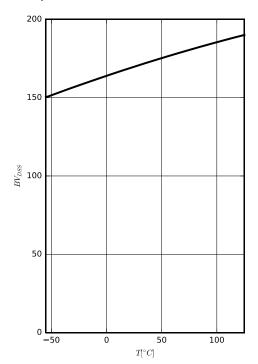
8 Typ. gate threshold voltage

$$I_D = f(T_j)$$



# 10 Typ. drain-source breakdown voltage

 $\begin{array}{l} \mathsf{BV}_{\mathsf{DSS}} = \mathsf{f}(\mathsf{T}_{\mathsf{j}}) \\ \mathsf{I}_{\mathsf{D}} = 250 \mu \mathsf{A} \end{array}$ 

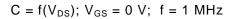


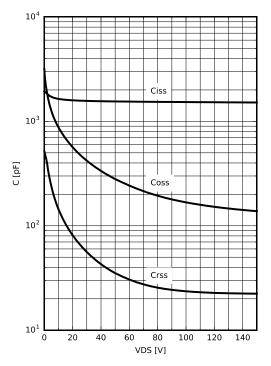


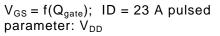
### Data Sheet

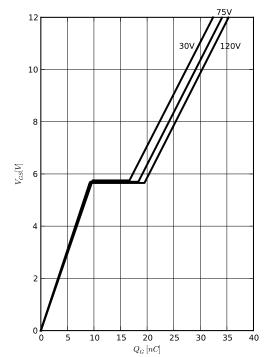
# BUY15CS23K-01 12 Typ. gate charge

## 11 Typ. capacitances



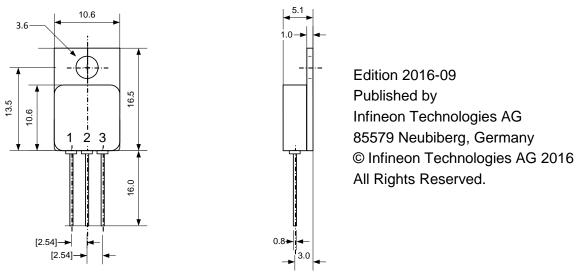








# TO-257AA Package



Dimensions are typical [mm]

### Caution

This package contains beryllia. Therefore it must not be in any form machined, grinded, sanded, polished or any other mechanical operation which will produce dust and particles.

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